Comparative Study of the Shielding Properties of Slotted Enclosure with Inner or Outer Excitations Using FEM

Baolin Nie, Pingan Du
School of Mechatronics Engineering, University of Electronic Science and Technology of China, Chengdu, China
Email: nblmiracle@gmail.com

Received 2013

ABSTRACT

Finite element method (FEM) is employed in this paper to conduct the comparative study of the shielding properties of enclosure with outer and inner excitations. Plane wave is adopted for the outer excitation case while coaxial cable is utilized to model the inner excitation source. Moreover, the resonance phenomena of slotted enclosure under different excitation are studied in detail. Finally, some conclusions with regard to the relationships and distinctions between the inner and outer excitations for the same enclosure are proposed.

Keywords: FEM; Plane Wave; Shielding; Wave Port

1. Introduction

The penetration of electromagnetic fields through slot has been of considerable interest because of its crucial influence on the shielding performance. As a result, numerous approaches have been proposed to quantify the shielding properties of enclosures with aperture and slot. One class of approaches uses outer excitation [1-3]. Usually, plane wave is adopted as source to excite the entire system. These approaches become prevalent mainly because they are simple and easy to implement. Another class of approaches utilizes inner excitation such as wave port or current probe to excite the system [4,5]. These approaches are more complicated because the electromagnetic radiation properties of excitation source are dependent on the position of observation point.

In this paper, the well-established FEM [6] is employed to investigate the shielding properties of enclosure with outer or inner excitation. The resonance phenomena of slotted enclosure are studied in detail. Finally, some conclusions which are useful for shielding design are proposed.

2. Shielding Models and FEM Description

2.1. Shielding Model

The geometrical model from Reference [4] is taken in this study for comparison and validation purpose. The geometry of the enclosure with a slot is shown in Figure 1. The enclosure is excited by coaxial cable with characteristic impedance of 50 Ω. The center conductor of the coaxial cable extends to span the width of the cavity with a 0.16-cm-diameter wire and terminated on the opposite cavity wall with a 47 Ω resistor. The enclosure is constructed of five pieces of 0.635-cm-thick metal, and one plate of 0.05-cm-thick metal for the side containing the slot. The interior dimensions of the enclosure are 22 × 14 × 30 cm. The coaxial cable at x = 17 cm, z = 15 cm, with a center conductor along y axis, is employed as an excitation source. A 12 × 0.1 cm slot located on the front plate is 0.2 cm away from the bottom edge.

2.2. Brief FEM Description

For simplicity, let us consider an electromagnetic problem defined in a volume denoted by $V$ and bounded by perfect conducting surface (PEC), waveguide port boundary condition (WPBC) and absorbing boundary condition (ABC). Besides, lumped resistor has to be incorporated into FEM to appropriately model the inner excitation source. By applying Galerkin’s method, the corresponding weak-form solution of the boundary-value problem
described above is given as
\[
\begin{align*}
\int_V \left\{ -\frac{1}{\mu_r} (\nabla \times N_j) \cdot (\nabla \times E) - k_0^2 \epsilon_r N_j \cdot E \right\} dV \\
+ j k_0 \int_{S_e} (\hat{n} \times N_j) \cdot (\hat{n} \times E) \, dS \\
- \int_{S_p} \frac{1}{\mu_{rg}} N_j \cdot P^2(E) \, dS \\
= -\int_{S_p} \frac{1}{\mu_{rg}} N_j \cdot U^{inc} \, dS - \sum_{S_n} N_j \cdot U^{inc} \, dS
\end{align*}
\] (1)

where
\[
\begin{align*}
U^{inc} &= \hat{n} \times (\nabla \times E^{inc}) + P^i (E^{inc}), \\
U^{inc2} &= \hat{n} \times (\nabla \times E^{inc}) + P^i (E^{inc}), \\
P^i(E) &= j k_0 \hat{n} \times (\hat{n} \times E), \\
P^2(E) &= -j \epsilon_0^{\text{TEM}} \epsilon_0^{\text{TEM}} \int_{S_p} \epsilon_0^{\text{TEM}} \cdot E \, dS \\
\epsilon_0^{\text{TEM}} &= \frac{1}{\sqrt{2\pi \ln(b/a)}} \frac{1}{\rho}
\end{align*}
\]

and \( N_j \) denote testing functions. Expanding the electric field as
\[
E(r, t) = \sum_{i=1}^{N} E_i N_j(r)
\] (2)

with \( N \) denoting the total number of unknowns.

The physical meanings of the variables in the above equations are shown in Table 1. For the plane wave source case, the excitation applies on the ABC surface. We have \( P^2(E) = U^{inc2} = 0 \), and \( E^{inc} \) has the uniform plane wave form. While for the wave port source case, the excitation applies on the port surface. We have \( U^{inc} = 0 \), and \( E^{inc} \) is set to be the same with \( \epsilon_0^{\text{TEM}} \).

For simplicity, we have omitted the spatial dependant factor in equations (1)-(4), all the vectors should be function of position vector \( r \), and this abbreviation method applies in the following sections.

### Table 1. Variables and their meaning.

<table>
<thead>
<tr>
<th>Variable</th>
<th>Meaning</th>
</tr>
</thead>
<tbody>
<tr>
<td>( \epsilon_r )</td>
<td>Relative permittivity of the medium</td>
</tr>
<tr>
<td>( \mu_r )</td>
<td>Relative permeability of the medium</td>
</tr>
<tr>
<td>( \mu_{rg} )</td>
<td>Relative permeability of the medium filled in wave port</td>
</tr>
<tr>
<td>( k_0 )</td>
<td>Wave number of coaxial cable</td>
</tr>
<tr>
<td>( \gamma_s = -jk_s )</td>
<td>Propagation constant of coaxial cable</td>
</tr>
<tr>
<td>( \hat{n} )</td>
<td>Unit vector normal to boundary surface</td>
</tr>
<tr>
<td>( \hat{\rho} )</td>
<td>Unit vector in radial direction of coaxial cable</td>
</tr>
<tr>
<td>( a )</td>
<td>Inner radius of the coaxial cable</td>
</tr>
<tr>
<td>( b )</td>
<td>Outer radius of the coaxial cable</td>
</tr>
<tr>
<td>( E^{inc} )</td>
<td>For plane wave source, it is plane wave. For wave port source case, it is the same as ( \epsilon_0^{\text{TEM}} ).</td>
</tr>
</tbody>
</table>

By substituting (2) into (1), we obtain
\[
\sum_{j=1}^{N} K_j E_j = b_j \quad i = 1, 2, \ldots, N
\] (3)

where
\[
\begin{align*}
+ j k_0 \int_{S_e} (\hat{n} \times N_j) \cdot (\hat{n} \times E) \, dS \\
- \int_{S_p} \frac{1}{\mu_{rg}} N_j \cdot P^2(E) \, dS \\
= -\int_{S_p} \frac{1}{\mu_{rg}} N_j \cdot U^{inc} \, dS - \sum_{S_n} N_j \cdot U^{inc} \, dS
\end{align*}
\]

This formulation is called Galerkin’s formulation since the same functions are used for both expansion and testing. Equation (3) can be written compactly as
\[
K_j \mathbf{E} = \mathbf{b}
\] (4)

which can be solved for \( \{E\} \). Because the elemental interactions in (3) are local in nature, \( \mathbf{K} \) is a sparse and symmetric matrix that can be solved efficiently using a sparse matrix solver. Once \( \{E\} \) is obtained, the field everywhere in \( V \) can be calculated using (2), from which other parameters, such as the input impedance and radiation patterns, can be computed.

### 3. Results

For the plane wave excitation case, the shielding performance is measured by shielding effectiveness (SE)
\[
\text{SE(dB)} = -20 \log \left( \frac{|E^{\text{int}}|}{|E^{\text{ext}}|} \right)
\] (5)

where \( E^{\text{int}} \) is the electric field at a given point inside the enclosure and \( E^{\text{ext}} \) is the field at the same point in absence of the enclosure.

For the coaxial cable excitation case, the power delivered to the enclosure is related to the reflection coefficient as
\[
P = \frac{V_s^2}{8Z_0} \left( 1 - S_{11}^2 \right)
\] (6)

where \( V_s \) is the source voltage and \( Z_0 \) is the source impedance. In this study, the source voltage is 1 V and the source impedance equals the characteristic impedance of the coaxial cable (50 \( \Omega \)), so the maximum power available at the source terminal is 2.5 mW. Scattering parameter \( S_{11} \) at the coaxial cable port can be extracted as
\[
S_{11} = \frac{\int_{S_p} (E \cdot E^{inc}) \cdot E^{inc} \, dS}{\int_{S_p} |E^{inc}|^2 \, dS}.
\] (7)
Figure 2 shows the power delivered to the enclosure. The measurement result from [4] is also presented here for validation purpose. It can be seen from the figures that the FEM simulation results agree with measurement results well in general. This guarantees the correctness of the following simulations.

Figure 3 shows the resonance points and their attributes of enclosure with the slot. Figure 4 shows the SE and resonance points of the enclosure for $Y$-polarized plane wave excitation. Figure 5 shows the SE and resonance points of the enclosure for $Z$-polarized plane wave excitation. The value of their resonance points are listed in Table 2, Table 3, and Table 4, respectively.

By comparing Figure 3 and Figure 4 we can see that the TEM resonance at 1.08 GHz due to probe half wavelength resonance disappears when we change the excitation source from coaxial cable to plane wave. At the same time, $TE_{y012}$ mode is excited while $TM_{y111}$ mode and $TM_{y201}$ mode are suppressed. Besides, the resonance frequency of $TM_{y101}$ mode decreases since the terminated feed probe is removed. The slot resonance is due to the half wavelength resonance since the length of slot equals to half wavelength at about 1.2 GHz. So this resonance remains for both configurations. It also shows that the same enclosure can have very different resonance behavior when it is excited by different sources. One should keep this in mind when involved in the design of shielding enclosures because the resonance is the most crucial part in this process.

By comparing Figure 4 and Figure 5 we can see that the SE of the enclosure increases significantly when we change the excitation source from $Y$-polarized plane wave to $Z$-polarized plane wave. This is because the aperture greatly cuts into the path of induced current and breaks the integrality of shielding for $Y$-polarized case. It can be deduced form Table 3 and Table 4 that the slot...
Table 2. Resonance points of the enclosure with inner excitation.

<table>
<thead>
<tr>
<th>Modes</th>
<th>Frequency (GHz)</th>
</tr>
</thead>
<tbody>
<tr>
<td>$TM_{y101}$</td>
<td>0.89</td>
</tr>
<tr>
<td>$TEM$</td>
<td>1.08</td>
</tr>
<tr>
<td>cavity-slot</td>
<td>1.12</td>
</tr>
<tr>
<td>slot</td>
<td>1.23</td>
</tr>
<tr>
<td>$TM_{y111}$</td>
<td>1.37</td>
</tr>
<tr>
<td>$TM_{y201}$</td>
<td>1.43</td>
</tr>
<tr>
<td>cavity-slot</td>
<td>1.53</td>
</tr>
</tbody>
</table>

Table 3. Resonance points of the enclosure with outer $Y$-polarized plane wave excitation.

<table>
<thead>
<tr>
<th>Modes</th>
<th>Frequency (GHz)</th>
</tr>
</thead>
<tbody>
<tr>
<td>$TM_{y101}$</td>
<td>0.84</td>
</tr>
<tr>
<td>cavity-slot</td>
<td>1.16</td>
</tr>
<tr>
<td>slot</td>
<td>1.25</td>
</tr>
<tr>
<td>cavity-slot</td>
<td>1.40</td>
</tr>
<tr>
<td>$TE_{y012}$</td>
<td>1.47</td>
</tr>
</tbody>
</table>

Table 4. Resonance points of the enclosure with outer $Z$-polarized plane wave excitation.

<table>
<thead>
<tr>
<th>Modes</th>
<th>Frequency (GHz)</th>
</tr>
</thead>
<tbody>
<tr>
<td>$TM_{y101}$</td>
<td>0.84</td>
</tr>
<tr>
<td>cavity-slot</td>
<td>1.16</td>
</tr>
<tr>
<td>$TM_{y102}$</td>
<td>1.21</td>
</tr>
<tr>
<td>$TE_{y110}$</td>
<td>1.27</td>
</tr>
<tr>
<td>cavity-slot</td>
<td>1.40</td>
</tr>
<tr>
<td>$TE_{y012}$</td>
<td>1.47</td>
</tr>
</tbody>
</table>

resonance is absent when the excitation source is $Z$-polarized plane wave. But the two resonance points associated with coupling of cavity and slot exist. Moreover, $TMy102$ mode and $TEy110$ mode are excited.

4. Conclusions

In this paper, the FEM is employed to investigate the shielding properties of slotted enclosure with outer or inner excitation. The resonance phenomena of slotted enclosure are studied in detail for both inner and outer excitations. Different polarization configurations of incident plane wave for the outer excitation case are also investigated, especially for their resonance behavior. It also shows that the same enclosure can have very different resonance behavior when it is excited by different sources, Which could be helpful for shielding enclosure design.

5. Acknowledgements

The authors thank the National Natural Science Foundation of China (Grant No. 51175068), the China Scholarship Council (CSC), and the Fundamental Research Funds for the Central Universities of China for their supporting.

REFERENCES


